

# Resonant Band Engineering of Ferroelectric Tunnel Junctions

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We propose energy band engineering to enhance tunneling electroresistance (TER) in ferroelectric tunnel junctions (FTJs). We predict that an ultrathin dielectric layer with a smaller band gap, embedded into a ferroelectric barrier layer, acts as a switch controlling high and low conductance states of an FTJ depending on polarization orientation. Using first-principles modeling based on density functional theory, we investigate this phenomenon for a prototypical SrRuO<sub>3</sub>/BaTiO<sub>3</sub>/SrRuO<sub>3</sub> FTJ with a BaSnO<sub>3</sub> monolayer embedded in the BaTiO<sub>3</sub> barrier. We show that in such a composite-barrier FTJ, ferroelectric polarization of BaTiO<sub>3</sub> shifts the conduction band minimum of the BaSnO<sub>3</sub> monolayer above or below the Fermi energy depending on polarization orientation. The resulting switching between direct and resonant tunneling leads to a TER effect with a giant ON/OFF conductance ratio. The proposed resonant band engineering of FTJs can serve as a viable tool to enhance their performance useful for device application.

A ferroelectric tunnel junction (FTJ) is a functional electronic device with electrical resistance being controlled by ferroelectric polarization [1]. A typical FTJ is composed of two conducting electrodes separated by a nanometer-thick ferroelectric layer, which serves as a tunnel barrier. A figure of merit of an FTJ is tunneling electroresistance (TER)—a resistance change resulting from polarization reversal of the ferroelectric barrier layer [2,3]. Such polarization switching allows the control of two non-volatile resistance states of an FTJ (low and high) which can be employed in random access memories and other electronic devices [4]. Enhancing the magnitude of TER is beneficial for device application of FTJs.

There are several physical mechanisms responsible for the TER effect [5]. Most of them involve a modulation of the effective tunneling barrier encountered by transport electrons and driven by reversal of ferroelectric polarization [6]. Different microscopic processes control the tunneling barrier in FTJs, involving those at the interfaces, within the electrodes, as well as in the ferroelectric layer itself. An important prerequisite for obtaining a large TER is asymmetry of the FTJ in respect to its electronic and atomic structure. Specifically, it has been demonstrated that sizable TER can be obtained using dissimilar electrodes [7-13], a composite barrier layer [14-17], and interface engineering [18-22]. Interesting physical phenomena have been predicted and demonstrated in FTJs, including ferroelectric-induced magnetic interface phase transition [23-25], tunneling barrier metallization [26, 27], defect-controlled [28-32] and bias-modulated [33, 34] transport, and tunneling across an in-plane domain wall [35, 36].

Despite this notable progress, further improvements in the FTJ performance are required to meet industry demands. Nowadays, due to advances in thin-film deposition techniques, growth of thin-film heterostructures can be controlled with the atomic scale precision. This allows tuning the atomic structure of FTJs within a single atomic layer to achieve the required

electronic and transport properties. For example, using a layer-by-layer growth,  $\delta$ -doping can be realized to improve the performance of FTJs and associated electronic devices.

In this work, we propose that the transport properties of FTJs can be significantly enhanced by inserting an ultrathin layer of a dielectric with a relatively smaller band gap in the ferroelectric barrier. Such a dielectric layer produces resonant states in the barrier energy gap which can be controlled by ferroelectric polarization. Polarization reversal shifts the conduction band of the dielectric layer up and down with respect to the Fermi level, which results in the switching of the transport regime between direct and resonant tunneling. Such a resonant-band control strongly enhances an ON/OFF conductance ratio of FTJs and provides a practical tool to engineer their electronic and transport properties to meet industry requirements.

To explore this mechanism of TER, we consider a prototypical FTJ which consists of SrRuO<sub>3</sub> electrodes and BaTiO<sub>3</sub> ferroelectric barrier with one TiO<sub>2</sub> atomic layer being substituted with SnO<sub>2</sub>. The substitution of SnO<sub>2</sub> for TiO<sub>2</sub> can be thought as insertion of one-unit-cell-thick BaSnO<sub>3</sub> layer instead of that of BaTiO<sub>3</sub>. BaSnO<sub>3</sub> has been predicted to exhibit a conduction band offset with respect to BaTiO<sub>3</sub> as large as  $-1.13$  eV [37]. In addition, BaSnO<sub>3</sub> has a similar lattice constant to BaTiO<sub>3</sub> and both BaTiO<sub>3</sub> and BaSnO<sub>3</sub> can grow epitaxially on SrTiO<sub>3</sub> [38]. Thus, if such a one-unit-cell-thick BaSnO<sub>3</sub> layer is inserted in the tunneling barrier, the conduction band minimum (CBM) of this layer will be shifted down with respect to the CBM of BaTiO<sub>3</sub>, affecting the transport mechanism. When the polarization of BaTiO<sub>3</sub> is switched between two polarization states, the CBM of BaSnO<sub>3</sub> will be pushed up and down in energy, above and below the Fermi level, so that the conduction mechanism changes from direct to resonant tunneling. This will lead to a large change in resistance of the FTJ and thus a sizable TER effect.

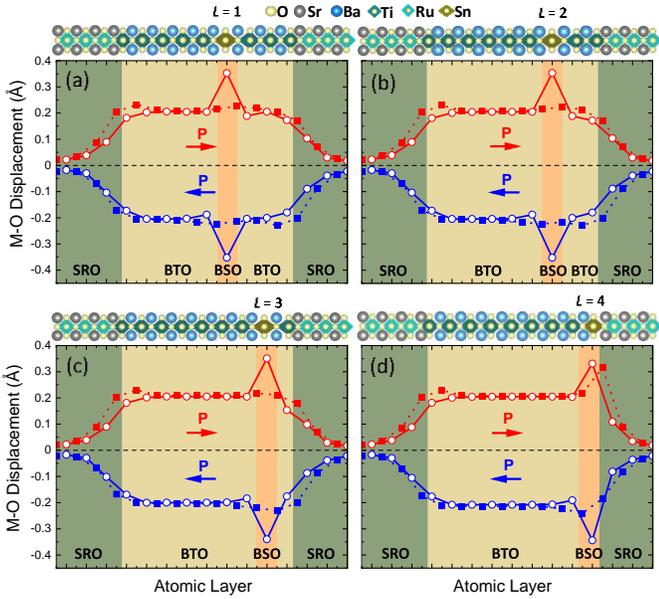


FIG. 1. Calculated relative polar displacement between cation (M) and anion (O) on each AO ( $A = \text{Ba}$  or  $\text{Sr}$ ) and  $\text{BO}_2$  ( $B = \text{Ti}$ ,  $\text{Sn}$ , or  $\text{Ru}$ ) layer across  $\text{SrRuO}_3/\text{BaTi}(\text{Sn})\text{O}_3/\text{SrRuO}_3$  supercells (top panels) with a  $\text{SnO}_2$  monolayer placed at four different positions numbered by  $L = 1$  (a),  $L = 2$  (b),  $L = 3$  (c), and  $L = 4$  (d) as indicated by orange vertical bars. Positive (negative) values of the displacement shown in red (blue) correspond to polarization pointing to the right (left). Open (solid) symbols denote Ti-O, Sn-O, and Ru-O (Ba-O and Sr-O) displacements.

To confirm these expectations, we perform first-principles calculations, as described in Supplemental Material [39]. In the calculations, we use a supercell constructed of 8.5 unit cells of  $\text{BaTiO}_3$  with one atomic layer of  $\text{TiO}_2$  substituted by  $\text{SnO}_2$  and 6.5 unit cells of  $\text{SrRuO}_3$ . The  $\text{SnO}_2$  is placed at four different positions numbered by  $L$ , as indicated on top panels of Figs. 1 (a-d). To simulate coherent epitaxial growth of the structure on an  $\text{SrTiO}_3$  substrate in experiment, we constrain the in-plane lattice constant of the supercell to the calculated lattice constant of cubic  $\text{SrTiO}_3$ ,  $a = 3.94 \text{ \AA}$ . This constraint imposes an in-plane strain of about  $-1.5\%$  on  $\text{BaTiO}_3$  and stabilizes  $\text{BaTiO}_3$  in the  $P4mm$  tetragonal phase. Under this constraint, the calculated direct bands gap of  $\text{BaTiO}_3$  and  $\text{BaSnO}_3$  are found to be 2.5 eV and 1.2 eV, respectively. The smaller band gap of  $\text{BaSnO}_3$  leads to the appearance of quantum-well states in the band gap of  $\text{BaTiO}_3$ , when Sn is substituted for Ti in a monolayer or two monolayers of  $\text{BaTiO}_3$  [39].

We find that ferroelectric polarization is switchable in all FTJ structures independent of the position of the inserted  $\text{SnO}_2$  layer. Figs. 1 (a-d) show the respective cation-anion displacement at each AO ( $A = \text{Ba}$  or  $\text{Sr}$ ) and  $\text{BO}_2$  ( $B = \text{Ti}$ ,  $\text{Sn}$ , or  $\text{Ru}$ ) atomic layer in these FTJs for polarization pointing left (blue curves) and right (red curves). The Ti-O and Ba-O displacements in the barrier layer are consistent with the previous calculations for pure  $\text{BaTiO}_3$  [40], reflecting a bulk-like polarization of  $\text{BaTiO}_3$  independent of the position of the

$\text{SnO}_2$  layer. It is notable that the  $\text{SnO}_2$  layer itself behaves as a strong dipole which is signified by a large Sn-O displacement. The presence of the Ru-O and Sr-O displacement, decaying away from the interface into the  $\text{SrRuO}_3$  electrode, reflects the effect of ionic screening [41].

Fig. 2 shows the calculated local density of states (LDOS) projected on  $\text{TiO}_2$  and  $\text{SnO}_2$  layers. It is seen that there is band bending across the barrier due to a depolarizing field, whose direction depends on polarization orientation. For polarization pointing right (Figs. 2 (a-d)), the CBM on the  $\text{SnO}_2$  layer quickly approaches the Fermi energy  $E_F$  when this layer is moved from the middle of the barrier layer ( $L = 1$ ) to the interface ( $L = 4$ ). When  $\text{SnO}_2$  is in layer  $L = 2$ , i.e. two  $\text{TiO}_2$  layers away from the right interface (Fig. 2 (b)), the  $\text{SnO}_2$  LDOS touches  $E_F$ , and when it is in layer  $L = 3$  (Fig. 2 (c)), bottom of the  $\text{SnO}_2$  LDOS lies about 0.2 eV below  $E_F$ . In contrast, for polarization pointing left (Figs. 2 (e-h)), the CBM on the  $\text{SnO}_2$  layer lies well above the Fermi level due to the asymmetric placement of this layer closer to the right interface.

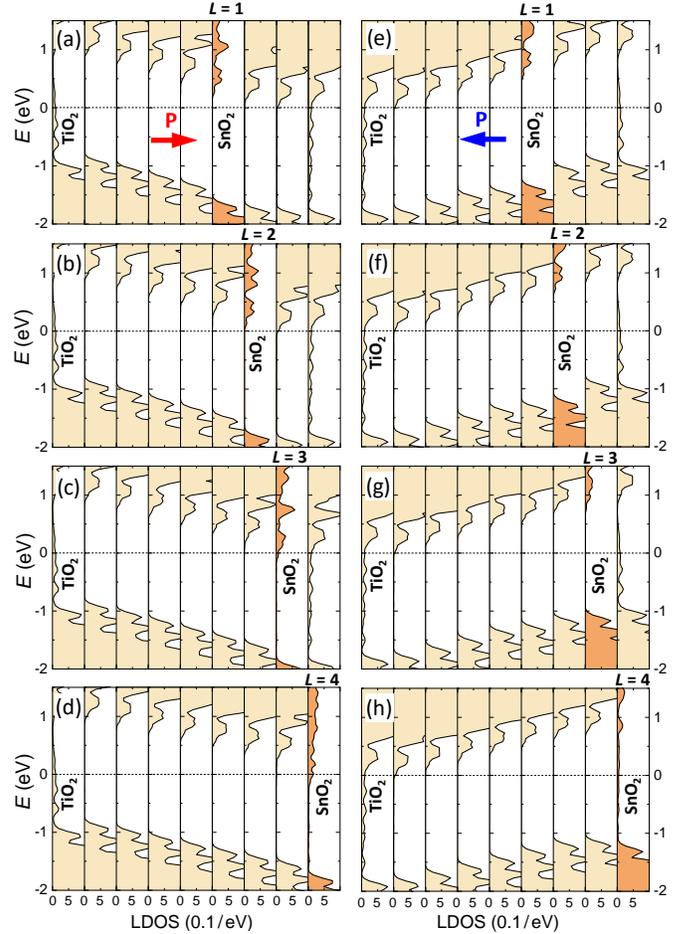


FIG. 2. Local densities of states (LDOS) as a function of energy  $E$  on each  $\text{BO}_2$  ( $B = \text{Ti}$ ,  $\text{Sn}$ ) atomic layer within a composite  $\text{BaTi}(\text{Sn})\text{O}_3$  barrier for four FTJ structures with  $\text{SnO}_2$  layer at  $L = 1$  (a, e),  $L = 2$  (b, f),  $L = 3$  (c, g), and  $L = 4$  (d, h) for polarization pointing right (a-d) and left (e-h). Horizontal dashed lines indicate the Fermi energy.

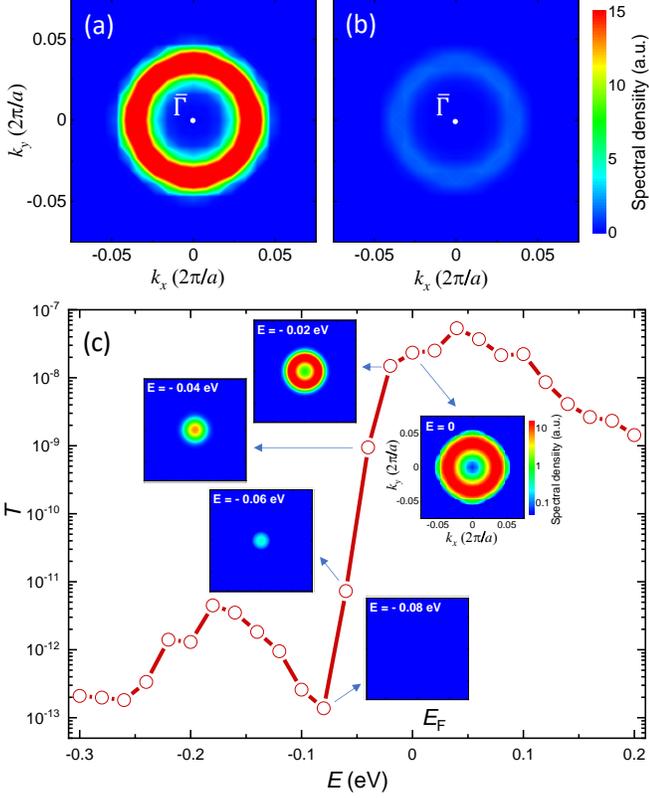


FIG. 3. Spectral density around the  $\bar{\Gamma}$  point ( $k_{\parallel} = 0$ ) projected onto the SnO<sub>2</sub> (a) and interfacial TiO<sub>2</sub> (b) layers at the Fermi energy for SrRuO<sub>3</sub>/BaTiO<sub>3</sub>(BaSnO<sub>3</sub>)/SrRuO<sub>3</sub> FTJ with SnO<sub>2</sub> layer at  $L = 3$  and ferroelectric polarization pointing to the right. (c) Transmission  $T$  per unit-cell area of the FTJ as a function of electron energy  $E$ . The Fermi energy  $E_F$  is at zero. Insets display spectral densities in the logarithmic scale at  $E = 0, -0.02, -0.04, -0.06$ , and  $-0.08$  eV.

The appearance of the SnO<sub>2</sub> electronic states at the Fermi energy provides a resonant channel for conductance, which is responsible for a large TER effect discussed below. The presence of resonant states is evident from Fig. 3 (a) showing the spectral density (SD) on the SnO<sub>2</sub> layer around the  $\bar{\Gamma}$  point ( $k_{\parallel} = 0$ ) at  $E_F$  for FTJ with SnO<sub>2</sub> placed at  $L = 3$  (corresponding to the LDOS in Fig. 2 (c)). The high SD at a ring of radius  $k_{\parallel} \approx 0.035 \frac{2\pi}{a}$  indicates the presence of a 2D free-electron-like band localized within the SnO<sub>2</sub> layer. While the adjacent interfacial TiO<sub>2</sub> layer at the right interface is also metalized (as follows from the non-zero LDOS at  $E_F$  in Fig. 2 (c)), it has a very small SD in the area around the  $\bar{\Gamma}$  point where the SnO<sub>2</sub> SD is sizable (Fig. 3 (b)). In fact, this TiO<sub>2</sub> SD represents SnO<sub>2</sub>-induced gap states, and the TiO<sub>2</sub>-layer metallization largely results from  $k_{\parallel}$  lying beyond the area shown in Fig. 3 (b). Therefore, the interfacial TiO<sub>2</sub> layer provides an effective barrier for tunneling electrons with transverse wave vectors  $k_{\perp}$  corresponding to the quantum-well states on SnO<sub>2</sub>.

When the electron energy  $E$  is shifted down below  $E_F$ , the SnO<sub>2</sub> spectral density shrinks to a ring of a smaller radius (insets

in Fig. 3 (c)) and then collapses to a point (inset in Fig. 3 (c) for  $E = -0.06$  eV). At  $E = -0.08$  eV, there are no resonant states on SnO<sub>2</sub> and the transport across the FTJ is expected to occur via direct tunneling.

These expectations are confirmed by the computed transmission  $T$  as a function of energy  $E$  across the SrRuO<sub>3</sub>/BaTi(Sn)O<sub>3</sub>/SrRuO<sub>3</sub> FTJ with SnO<sub>2</sub> placed at  $L = 3$  and ferroelectric polarization pointing to the right. As seen from Fig. 3 (c), there is an onset of transmission at  $E = -0.08$  eV so that  $T$  increases by more than five orders in magnitude with the increasing energy up to  $E_F$ . This onset is due to the transition to a resonant tunneling regime. The upward trend results from the increasing number of quantum-well states contributing to transmission at a higher energy, as seen from insets in Fig 3.

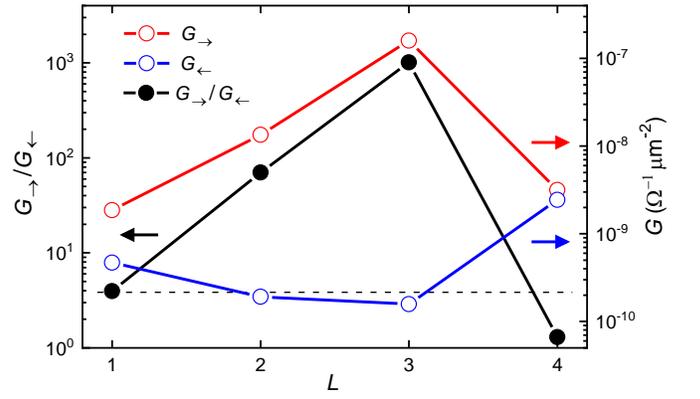


FIG. 4. Conductance  $G$  per lateral area of SrRuO<sub>3</sub>/BaTi(Sn)O<sub>3</sub>/SrRuO<sub>3</sub> FTJs as a function of SnO<sub>2</sub> layer position  $L$  in BaTiO<sub>3</sub> for polarization pointing right  $G_{->}$  (red dots) and left  $G_{<-}$  (blue dots) and corresponding ON/OFF conductance ratio  $G_{->}/G_{<-}$  (black dots). The dashed line shows the junction conductance without the SnO<sub>2</sub> layer.

Fig. 4 shows the calculated conductance per area  $G = \frac{2e^2 T}{h A}$  (where  $T$  is transmission and  $A$  is a lateral unit-cell area of the junction) of the FTJs with different positions of the SnO<sub>3</sub> layer for two polarization orientations. When polarization is pointing left, conductance  $G_{<-}$  does not change much as the SnO<sub>2</sub> layer is moved from the middle of the barrier to the right interface (blue dots in Fig. 4). This is because the SnO<sub>2</sub> LDOS is positioned well above  $E_F$  (Figs. 2 (e-h)), and SnO<sub>2</sub> acts as a normal barrier independent of its location. In this case, the transport mechanism is controlled by direct tunneling. However, when polarization is pointing right, conductance  $G_{->}$  increases fast when the SnO<sub>2</sub> layer is moved toward the interface from  $L = 1$  to  $L = 3$  and then drops down when the SnO<sub>2</sub> layer is placed at the interface,  $L = 4$  (red dots in Fig. 4). The increase in  $G_{->}$  is due to the band bending which pulls the SnO<sub>2</sub> LDOS down, reducing the tunneling barrier height. When SnO<sub>2</sub> is placed at  $L = 3$ , the SnO<sub>2</sub> LDOS crosses  $E_F$ , thus providing quantum-well states for resonant tunneling. Due to being separated from the SrRuO<sub>3</sub> electrode by an interfacial BaTiO<sub>3</sub> barrier layer, these

resonant states strongly enhance conductance. On the contrary, when  $\text{SnO}_2$  is placed at the interfacial layer  $L = 4$ , due to being in contact with conducting  $\text{SrRuO}_3$ , the  $\text{SnO}_2$  effectively serves as the termination of the metal electrode. In this case, the quantum well vanishes, electron transport is controlled by direct tunneling, and conductance  $G_{\rightarrow}$  drops down.

To obtain more insight into the mechanism of resonant tunneling, we calculate  $\mathbf{k}_{\parallel}$ -resolved transmission  $T(\mathbf{k}_{\parallel})$  across FTJs. As seen from Fig. 5, independent of the  $\text{SnO}_2$  position and polarization orientation,  $T(\mathbf{k}_{\parallel})$  exhibits a cross feature centered at the  $\bar{\Gamma}$  point in the 2D Brillouin zone. This feature is intrinsic to  $\text{BaTiO}_3$  whose  $\mathbf{k}_{\parallel}$ -dependent evanescent states reveal the lowest decay rates along the four  $\bar{\Gamma} - \bar{M}$  directions [42] and reflect direct tunneling across  $\text{BaTiO}_3$ . For polarization pointing left, we observe qualitatively similar  $T(\mathbf{k}_{\parallel})$  patterns controlled by the evanescent states of  $\text{BaTiO}_3$  and independent of the  $\text{SnO}_2$  location (Figs. 5 (e-h)). This behavior signifies the direct mechanism of tunneling.

On the contrary, for polarization pointing right,  $T(\mathbf{k}_{\parallel})$  exhibits a “hot spot” around the  $\bar{\Gamma}$  point with the transmission magnitude strongly dependent on the  $\text{SnO}_2$  location  $L$  (Figs. 5 (a-d)). The hot spot is most pronounced at  $L = 3$  (Fig. 5 (c)), where  $T$  is enhanced by four orders in magnitude near the  $\bar{\Gamma}$  point. Zooming in on the dashed-line square of Fig. 5 (c) reveals a ring feature in  $T(\mathbf{k}_{\parallel})$  around the  $\bar{\Gamma}$  point (left panel in Fig. 5 (c)) reminiscent to that in the spectral density (Fig. 3 (a)). This correspondence between the  $T(\mathbf{k}_{\parallel})$  and SD indicates that it is the  $\text{SnO}_2$  quantum-well states which are responsible for the enhanced conductance  $G_{\rightarrow}$  at  $L = 3$  due to resonant tunneling assisted by these states.

When  $\text{SnO}_2$  is shifted to  $L = 2$ , i.e. closer to the middle of the barrier, the intensity of the hot spot is reduced (Fig. 5 (b)). In this case, the  $\text{SnO}_2$  quantum-well band is shifted up in energy (Fig. 2 (b)) and the resonant transmission is featured by the  $T(\mathbf{k}_{\parallel})$  distribution peaked at the  $\bar{\Gamma}$  point (left panel in Fig. 5 (b)). The hot spot vanishes at  $L = 1$  (Fig. 5 (a)) due to the  $\text{SnO}_2$  band being pulled above the Fermi energy (Fig. 2 (a)). When the  $\text{SnO}_2$  layer is at the interface ( $L = 4$ ), it becomes the termination of the metal electrode. While there is an enhanced transmission near the  $\bar{\Gamma}$  point (Fig. 5 (d)), it has the distinctive cross feature reflecting the evanescent states in  $\text{BaTiO}_3$ .

We conclude therefore that both the polarization orientation and the placement of the  $\text{SnO}_2$  layer in the FTJ control the transport mechanism and conductance. While for polarization pointing left, the transport is governed by direct tunneling independent of the  $\text{SnO}_2$  position, for polarization pointing right, it strongly depends on the location of the  $\text{SnO}_2$  layer. In the latter case, when  $\text{SnO}_2$  is placed at the second ( $L = 3$ ) or third ( $L = 2$ )  $\text{BO}_2$  layer from the interface, the conductance is strongly enhanced due to resonant tunneling. The resulting ON/OFF conductance ratio reaches a factor of  $10^3$  (black symbols in Fig. 4) and could be enhanced even further by proper engineering of the FTJ [43]. These DFT results are corroborated

by a simple quantum-mechanical model of tunneling across a potential barrier which contains a quantum well [39].

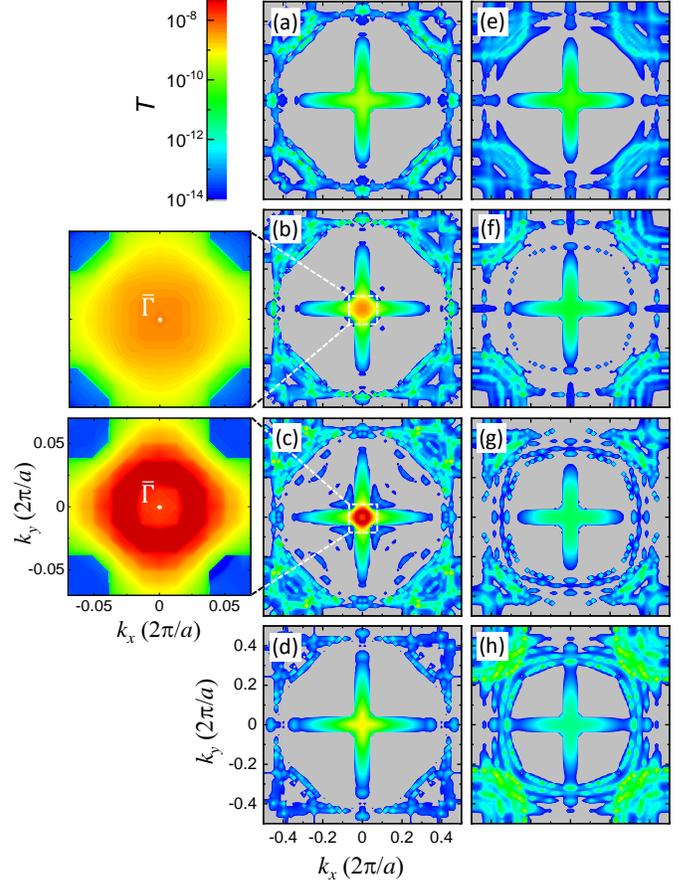


FIG. 5.  $\mathbf{k}_{\parallel}$ -resolved transmission across  $\text{SrRuO}_3/\text{BaTi}(\text{Sn})\text{O}_3/\text{SrRuO}_3$  tunnel junctions with the  $\text{SnO}_2$  layer at four different positions  $L = 1$  (a, e),  $L = 2$  (b, f),  $L = 3$  (c, g), and  $L = 4$  (d, h) for polarization pointing to the right (a-d) and left (e-h). Left panels in (b) and (c) show  $T(\mathbf{k}_{\parallel})$  zoomed in around the  $\bar{\Gamma}$  point ( $\mathbf{k}_{\parallel} = 0$ ).

In summary, we have proposed that resonant band engineering can serve as viable tool to control the mechanism of conductance and enhance the TER effect in FTJs. For a prototypical  $\text{SrRuO}_3/\text{BaTiO}_3/\text{SrRuO}_3$  FTJ, we demonstrated that a single  $\text{BaSnO}_3$  layer in the  $\text{BaTiO}_3$  barrier could form quantum-well states supporting resonant tunneling. The effect is dependent on polarization orientation serving as a switch between resonant and direct tunneling and resulting in a giant TER effect. The proposed approach can be further elaborated to design FTJs with required performance by proper engineering of barrier, resonant-band, and electrode materials and can be exploited to control spin polarization of the tunneling current. The predicted phenomenon is relevant to a ferroelectric field-effect transistor utilizing a  $\text{BaSnO}_3$  channel, which is expected to exhibit a relatively high mobility [44], and can be helpful in realizing a ferroelectric resonant tunneling diode [45, 46]. We hope therefore that our theoretical predictions will stimulate

experimental studies of FTJs and related functional oxide heterostructures with enhanced performance driven by the designed electronic bands.

The authors thank Ding-Fu Shao for valuable discussions. This work was supported by the National Natural Science Foundation of the People's Republic of China (Grants 11974211 and 11974212), Qilu Young Scholar Program of Shandong University, and Taishan Scholarship of Shandong

Province. Z.W. acknowledges support from the Taishan Scholar Program of Shandong Province (tsqn201812045). E.Y.T acknowledges support from NSF MRSEC (Grant DMR-1420645).

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results in an ON/OFF conductance ratio which can reach a factor of  $10^7$ .

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## SUPPLEMENTAL MATERIAL

### Resonant Band Engineering of Ferroelectric Tunnel Junctions

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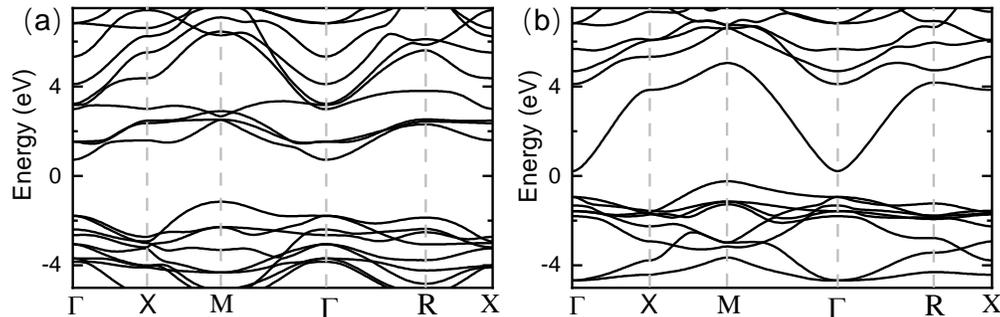
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#### A. Calculation Methods

First-principles density functional theory (DFT) calculations are performed using the plane-wave pseudopotential code Quantum ESPRESSO [1]. In the calculations, the exchange and correlation effects are treated within the generalized gradient approximation (GGA). The electron wave functions are expanded in a plane-wave basis set limited by a cut-off energy of 550 eV. Periodic boundary conditions are employed for a supercell constructed of 8.5 unit cells of BaTiO<sub>3</sub> with one atomic layer of TiO<sub>2</sub> substituted by SnO<sub>2</sub> and 6.5 unit cells of SrRuO<sub>3</sub> (see Fig. 1 in the main text). The in-plane lattice constant of the supercell is constrained to the calculated lattice constant of cubic SrTiO<sub>3</sub>,  $a = 3.94$  Å. Full internal relaxations are performed to determine the supercell lattice constant and the internal atomic configurations, using the force convergent criterion of 10 meV/Å. For the structural relaxation, the Brillouin zone is sampled with a 6×6×1 Monkhorst-Pack  $k$ -point mesh.

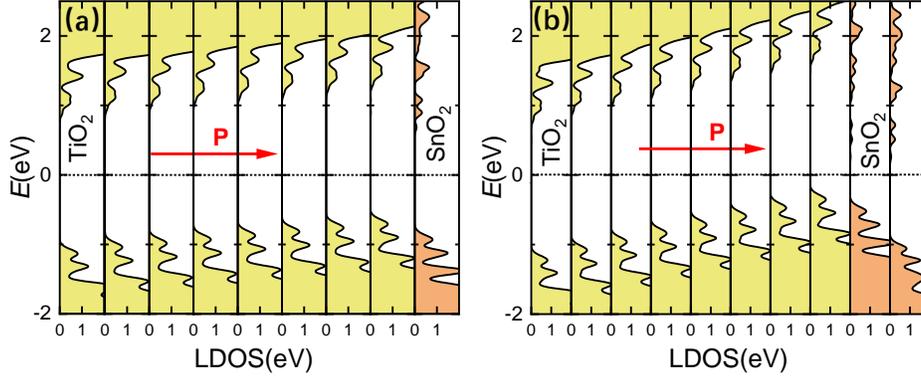
Transmission  $T$  is calculated using a general scattering formalism [2,3] implemented in Quantum-ESPRESSO. The above SrRuO<sub>3</sub>/BaTi(Sn)O<sub>3</sub>/SrRuO<sub>3</sub> supercells are used as scattering regions attached on both sides to semi-infinite SrRuO<sub>3</sub> leads. Such FTJ structure has periodic boundary conditions in the  $x$ - $y$  plane, as described by the transverse Bloch wave vector  $\mathbf{k}_{\parallel} = (k_x, k_y)$ .  $T$  is calculated using a uniform 80×80  $k_{\parallel}$  mesh in the two-dimensional (2D) Brillouin zone.

#### B. Band Alignment between BaTiO<sub>3</sub> and BaSnO<sub>3</sub>



**FIG. S1.** Bulk band structure of strained BaTiO<sub>3</sub> (a) and BaSnO<sub>3</sub> (b).

Fig. S1 shows the calculated band structure of bulk BaTiO<sub>3</sub> and BaSnO<sub>3</sub> with the lattice constant of both in the (001) plane being strained to be  $a = 3.94 \text{ \AA}$ , which is the calculated lattice constant of SrTiO<sub>3</sub>. Under this constraint, the calculated direct bands gap of BaTiO<sub>3</sub> and BaSnO<sub>3</sub> at the  $\Gamma$  point are found to be 2.5 eV and 1.2 eV, respectively.



**FIG. S2.** Local densities of state (LDOS) as a function of energy  $E$  on  $BO_2$  ( $B = \text{Ti, Sn}$ ) atomic layers of the  $(\text{BaTiO}_3)_n/(\text{BaSnO}_3)_m$  superlattice with  $n = 8$  and  $m = 1$  (a) and  $m = 2$  (b).

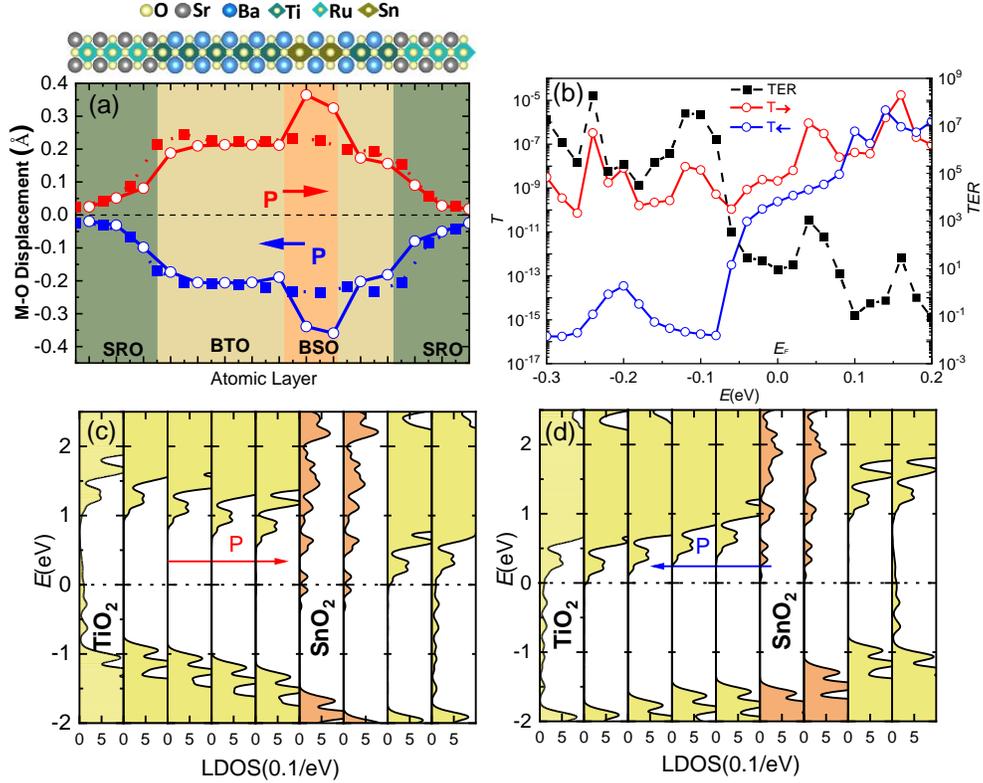
The smaller band gap of BaSnO<sub>3</sub> allows using Sn substitution for Ti in BaTiO<sub>3</sub> to form quantum-well states in the band gap of BaTiO<sub>3</sub> and thus use them for resonant-band engineering of FTJs. This is evident from our DFT calculations of superlattice heterostructures  $(\text{BaTiO}_3)_n/(\text{BaSnO}_3)_m$ , where Sn is substituted for Ti in a monolayer ( $m = 1$ ) or two monolayers ( $m = 2$ ) of (001) BaTiO<sub>3</sub>. Fig. S2 shows the calculated local densities of states (LDOS) on  $BO_2$  ( $B = \text{Ti, Sn}$ ) atomic layers across the heterostructure. It is seen that in both cases of  $m = 1$  (Fig. S2 (a)) and  $m = 2$  (Fig. S2 (b)), the conduction band minimum (CBM) at the SnO<sub>2</sub> layer is shifted below the CBM at the TiO<sub>2</sub> layers. The conduction band offset increases with the increasing BaSnO<sub>3</sub> thickness and produces quantum-well states in the band gap of BaTiO<sub>3</sub>. It is notable from Figs. S2 (a, b) that these quantum-well states reveal themselves as peaks in the LDOS near the CBM due to the confinement effect.

We note that in Figs. S2 (a,b), the TiO<sub>2</sub> LDOS exhibits a slope where the CBM and the valence band maximum (VBM) increase in energy along the direction of polarization. This is due to the bulk polarization of BaTiO<sub>3</sub> ( $40 \mu\text{C}/\text{cm}^2$ ) being *smaller* than that of BaSnO<sub>3</sub> ( $50 \mu\text{C}/\text{cm}^2$ ) under the constraint of the SrTiO<sub>3</sub> in-plane lattice constant. As a result, the electrostatic field in the  $(\text{BaTiO}_3)_n/(\text{BaSnO}_3)_m$  heterostructure is pointing *parallel* to the polarization within the BaTiO<sub>3</sub> layer and but *antiparallel* to the polarization within the BaSnO<sub>3</sub> layer.

### C. Resonant Tunneling across an FTJ with Two Layers of BaSnO<sub>3</sub>

Here we explore the effect of BaSnO<sub>3</sub> layer thickness on resonant tunneling and TER by considering a SrRuO<sub>3</sub>/BaTi(Sn)O<sub>3</sub>/SrRuO<sub>3</sub> FTJ with two atomic layers of BaSnO<sub>3</sub> inserted in the barrier. DFT calculations of the electronic structure and transmission are performed as described in sec. A. Fig. S3 (a) shows the atomic displacements across the FTJ for polarization pointing to left and right (blue and red curves in Fig. S3 (a), respectively). Similar to

the FTJ with one inserted monolayer of BaSnO<sub>3</sub> (Fig. 1 in the main text), we observe an enhancement of polar displacement at the SnO<sub>2</sub> layers. The calculated LDOS on BO<sub>2</sub> ( $B = \text{Ti, Sn}$ ) atomic layers for the two polarization states is shown in Figs. S3 (c, d). It is seen that the LDOS also exhibits features similar to those for the FTJ with one inserted atomic layer of BaSnO<sub>3</sub> (Figs. 2 (b, f) in the main text). The major difference, however, is a deeper shift of the SnO<sub>2</sub> quantum well-states into the band gap of BaTiO<sub>3</sub>, which is consistent with the LDOS of the (BaTiO<sub>3</sub>) <sub>$n$</sub> /(BaSnO<sub>3</sub>) <sub>$m$</sub>  superlattice shown in Fig. S2 (b). Also, similar to Fig. S2 (b), the confinement of the BaSnO<sub>3</sub> bands is reflected in the splitting of the LDOS near the CBM.



**FIG. S3.** (a) Calculated relative polar displacement between cation (M) and anion (O) on each AO ( $A = \text{Ba or Sr}$ ) and BO<sub>2</sub> ( $B = \text{Ti, Sn, or Ru}$ ) atomic layer across the SrRuO<sub>3</sub>/BaTi(Sn)O<sub>3</sub>/SrRuO<sub>3</sub> supercell (top panel) with two layers of SnO<sub>2</sub> substituted for TiO<sub>2</sub> in the BaTiO<sub>3</sub> barrier. (b) Transmission  $T$  per unit-cell area of the FTJ for polarization pointing right (left)  $T_{\rightarrow}$  ( $T_{\leftarrow}$ ) and the TER ratio  $T_{\rightarrow}/T_{\leftarrow}$  as a function of electron energy  $E$ . The Fermi energy  $E_F$  is at zero. (c, d) Local densities of states (LDOS) as a function of energy  $E$  on each BO<sub>2</sub> ( $B = \text{Ti, Sn}$ ) atomic layer of the composite barrier for polarization pointing to the right (c) and left (d). Horizontal dashed lines indicate the Fermi energy.

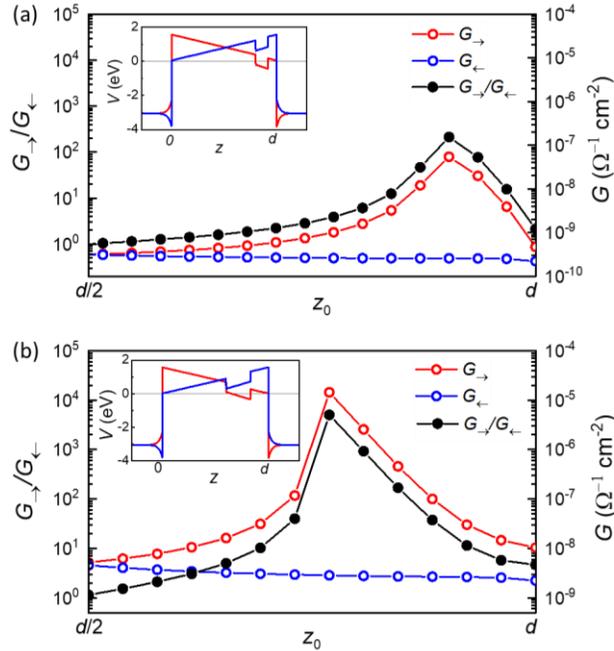
Comparing Figs. S3 (c) and (d) reveals that polarization switching changes the energy position of the SnO<sub>2</sub> LDOS with respect to the Fermi level. The CBM of the SnO<sub>2</sub> layer is shifted down in energy for polarization pointing to the right (Fig. S3 (c)), as compared to that for polarization pointing to the left (Fig. S3 (d)). While for the former, the Fermi level crosses the conduction bands of the SnO<sub>2</sub> layer, for the latter, the Fermi level lies nearly at the CBM.

Fig. S3 (b) shows the calculated transmission for polarization pointing right (left)  $T_{\rightarrow}$  ( $T_{\leftarrow}$ ) and the TER ratio

$T_{\rightarrow}/T_{\leftarrow}$  as a function of electron energy  $E$ . It is seen that for polarization pointing right, the transmission  $T_{\rightarrow}$  is high over the whole range of energies  $E$  considered, i.e.  $-0.3 \text{ eV} < E < 0.2 \text{ eV}$ . This is due to the presence of the resonant states in this energy window (see Fig. S3 (c)). On the contrary, for polarization pointing left, the transmission  $T_{\leftarrow}$  exhibits an onset at  $E \approx -0.07 \text{ eV}$ , so that it increases by nearly six orders in magnitude with increasing energy  $E$  up to  $E_F$ . This onset is due to the transition to the resonant tunneling regime similar to that shown in Fig. 3 (c) in the main text. As a result, at  $E \approx -0.07 \text{ eV}$ , there is a crossover between high and low TER values. As seen from Fig. S3 (b), while for  $E < -0.07 \text{ eV}$ , the TER ratio varies in the range of  $10^5 - 10^8$ , for  $E > -0.07 \text{ eV}$ , it is reduced to  $1 - 10^3$ .

## D. Modeling of Resonant Tunneling

The predicted phenomenon is further elaborated using a simple free-electron model. Within this model, we consider an FTJ with a ferroelectric barrier layer, which contains a thin dielectric of a smaller band gap, placed between two semi-infinite metal electrodes. The electrodes are described using free-electron bands, the Fermi energy of  $3.0 \text{ eV}$  with respect to the bottom of the bands, and the Thomas-Fermi screening length of  $1 \text{ \AA}$ . The composite tunneling barrier has overall thickness  $d = 3.5 \text{ nm}$ , where the thickness of the dielectric layer is set to be  $0.4$  or  $0.8 \text{ nm}$ . The ferroelectric and dielectric layers are assumed to have the potential barrier heights of  $0.8 \text{ eV}$  and  $0.2 \text{ eV}$ , respectively, with respect to the Fermi energy. The electron effective mass  $m^*$  in the barrier region is assumed to be 2 times free-electron mass  $m_0$ . The polarization of the ferroelectric and dielectric layers are set to be  $40 \mu\text{C}/\text{cm}^2$  and  $50 \mu\text{C}/\text{cm}^2$ , respectively, as follows from our first-principles calculations using the Born effective charge method. The relative electric permittivity of the barrier is assumed to be  $\varepsilon = 90$ .



**FIG. S4.** Conductance per area  $G$  as a function of the position  $z_0$  of the dielectric layer of thickness  $0.4 \text{ nm}$  (a) and  $0.8 \text{ nm}$  (b) in the barrier of an FTJ for polarization pointing right  $G_{\rightarrow}$  (red dots) and left  $G_{\leftarrow}$  (blue dots) and the corresponding ON/OFF conductance ratio  $G_{\rightarrow}/G_{\leftarrow}$  (black dots). Total thickness of the composite barrier is  $d = 3.5 \text{ nm}$ . Insets show the potential profiles for

the largest values of  $G_{\rightarrow}/G_{\leftarrow}$ .

Using these parameters, we obtain the electrostatic potential profile  $V(z)$  across the whole FTJ using the Thomas-Fermi model (insets in Figs. S4 (a) and (b)). Then, the transmission  $T$  is calculated using the transfer matrix method. A proper numerical integration over the transverse wave vectors  $\mathbf{k}_{\parallel}$  is performed to calculate the conductance per area  $G$  of the FTJ.

Fig. S4 shows results for the calculated conductance as a function of the position  $z_0$  of the dielectric layer in the tunneling barrier. It is seen that, for the polarization pointing left (blue dots in the figure), the conductance  $G_{\leftarrow}$  does not change much when the dielectric layer is moved from the middle of the barrier ( $z_0 = d/2$ ) to the right interface ( $z_0 = d$ ). However, for the polarization pointing right (red dots in the figure), the conductance  $G_{\rightarrow}$  reveals a pronounced maximum for a certain position of the dielectric layer, resulting from the resonant tunneling effect. The ON/OFF conductance ratio  $G_{\rightarrow}/G_{\leftarrow}$  exhibits a maximum at the same position of the dielectric layer (black dots in Fig. S4). As seen from the inserts of Fig. S4, this maximum corresponds to the Fermi energy crossing of the quantum well, which is formed in the barrier by the dielectric layer. The results of this simple model are in a qualitative agreement with our first-principles calculations, further indicating that proper band engineering of an FTJ can be used to produce a giant TER effect due to resonant tunneling reversible by ferroelectric polarization.

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